

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/807,432	YOSHIDA ET AL.	
Examiner		Art Unit	Nam Huynh	

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*	B	US-2004/0049467	03-2004	Blair, Jeffrey D.	705/075
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	M	US-			

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**NON-PATENT DOCUMENTS**

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